

Search Notes

Application/Control No.

10/531,666

Examiner

Chau N. Nguyen

Applicant(s)/Patent under
Reexamination

TSUKAHARA ET AL.

Art Unit

2831

SEARCHED

Class	Subclass	Date	Examiner
174	115	12/20/05	CN
	117F		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text	12/20/05	CN